

NCE70T1K2F-VB Datasheet

N-Channel 700V (D-S) Power MOSFET

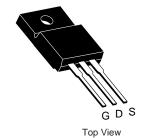
PRODUCT SUMMARY			
V _{DS} (V)	70	00	
R _{DS(on)} (Ω) at 25 °C	V _{GS} = 10 V	1.36	
Q _g Typ. (nC)	2	4	
Q _{gs} (nC)	(6	
Q _{gd} (nC)	1	1	
Configuration	Single		

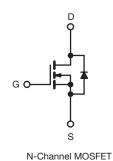
FEATURES



- Low Gate Charge Q_g Results in Simple Drive
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC







ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	700	V	
Gate-source voltage			V_{GS}	± 30	v	
Continuous drain current (T,I = 150 °C) e	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		7		
Continuous drain current (1) = 150 C)	V _{GS} at 10 V	T _C = 100 °C	I _D	5	Α	
Pulsed drain current ^a			I _{DM}	18		
Linear derating factor				0.63	W/°C	
Single pulse avalanche energy ^b			E _{AS}	56	mJ	
Maximum power dissipation			P_{D}	31	W	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Drain-source voltage slope	T _J = 125 °C		dV/dt	37	V/ns	
Reverse diode dV/dt ^d			αν/αι	27	V/IIS	
Soldering recommendations (peak temperature) c	For	10 s		300	°C	
Mounting torque	M3 s	screw		0.6	Nm	

- a. Repetitive rating; pulse width limited by maximum junction temperature b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=28.2 mH, $R_g=25$ Ω , $I_{AS}=2$ A c. 1.6 mm from case d. $I_{SD} \le I_D$, dI/dt=100 A/µs, starting $T_J=25$ °C e. Limited by maximum junction temperature



THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	43	65	°C/W
Maximum junction-to-case (drain)	R _{thJC}	3.1	4.0	G/VV

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static				L	L		
Drain-source breakdown voltage	V _{DS}	V _{GS} =	: 0 V, I _D = 250 μA	700	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.73	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = 250 μA	2	-	4	V
		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-source leakage	I _{GSS}	,	$I_{GS} = \pm 30 \text{ V}$	-	-	± 1	μΑ
		V _{DS} =	V _{DS} = 700 V, V _{GS} = 0 V		-	1	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 560 V	V _{DS} = 760 V, V _{GS} = 0 V V _{DS} = 560 V, V _{GS} = 0 V, T _J = 125 °C		-	10	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 3 A$	-	1.36	-	Ω
Forward transconductance	9 _{fs}	V _{DS}	V _{DS} = 30 V, I _D = 3 A		2	-	S
Dynamic		•			•	•	
Input capacitance	C _{iss}		V _{GS} = 0 V,		820	-	
Output capacitance	C _{oss}	,	$I_{\rm DS} = 100 \rm V,$	20	60	-	1
Reverse transfer capacitance	C_{rss}		f = 1 MHz	2	4	-	
Effective output capacitance, energy related ^a	C _{o(er)}			-	36	-	pF
Effective output capacitance, time related ^b	C _{o(tr)}	V _{DS} = 0 \	$V_{DS} = 0 \text{ V to } 560 \text{ V}, V_{GS} = 0 \text{ V}$		117	-	
Total gate charge	Qg			-	24	48	
Gate-source charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 3 \text{ A}, V_{DS} = 520 \text{ V}$		-	6	-	nC
Gate-drain charge	Q_{gd}				11	-	
Turn-on delay time	t _{d(on)}	V _{DD} = 560 V, I _D = 3 A,		-	14	28	
Rise time	t _r			-	12	24	no
Turn-off delay time	t _{d(off)}	V _{GS} =	$V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		30	60	ns
Fall time	t _f	1		-	20	40	
Gate input resistance	R_{g}	f = 1 MHz, open drain		0.4	1.4	2.7	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	showing the	MOSFET symbol showing the		-	7	
Pulsed diode forward current	I _{SM}	integral reverse p - n junction diode		-	-	18	_ A
Diode forward voltage	V _{SD}	T _J = 25 °C, I _S = 3 A, V _{GS} = 0 V		-	0.83	1.3	V
Reverse recovery time	t _{rr}	-		118	237	474	ns
Reverse recovery charge	Q _{rr}	$T_J = 2$	$T_J = 25 ^{\circ}\text{C}, I_F = I_S = 3 \text{A},$ $dI/dt = 100 \text{A/µs}, V_R = 25 \text{V}$		2.2	-	μC
Reverse recovery current	I _{RRM}	αι/ατ = 1υυ Α/μs ^{, ν} _R = 25 V		-	16	-	Α

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

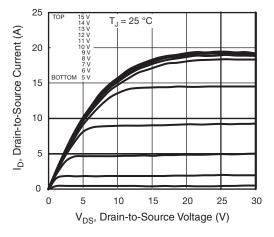


Fig. 1 - Typical Output Characteristics

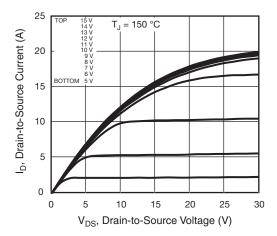


Fig. 2 - Typical Output Characteristics

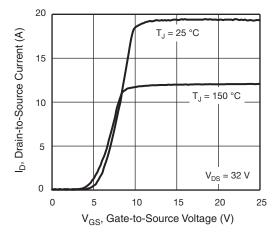


Fig. 3 - Typical Transfer Characteristics

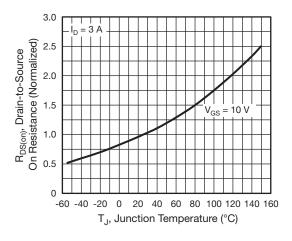


Fig. 4 - Normalized On-Resistance vs. Temperature

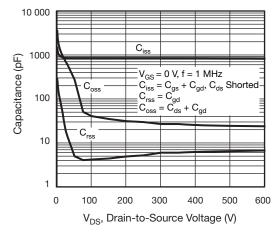


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

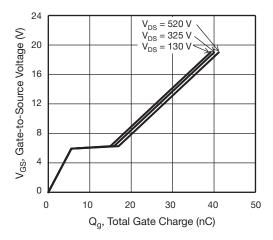


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



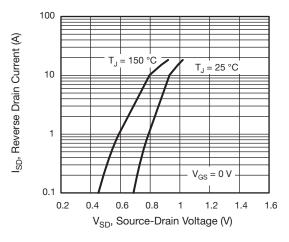


Fig. 7 - Typical Source-Drain Diode Forward Voltage

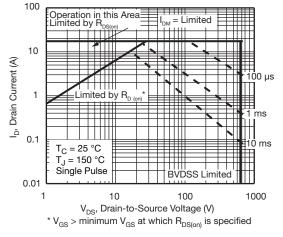


Fig. 8 - Maximum Safe Operating Area

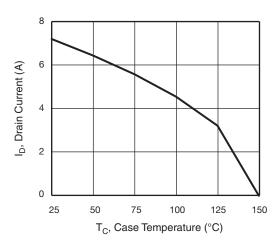


Fig. 9 - Maximum Drain Current vs. Case Temperature

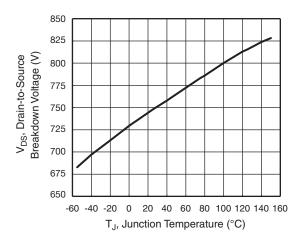


Fig. 10 - Temperature vs. Drain-to-Source Voltage

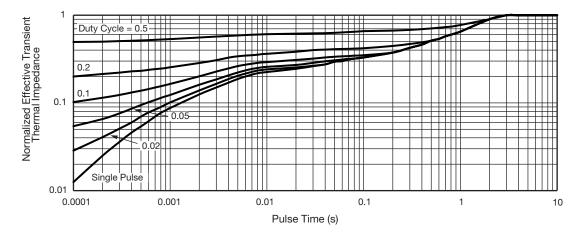


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



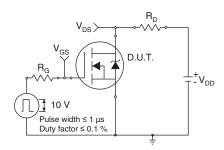


Fig. 12 - Switching Time Test Circuit

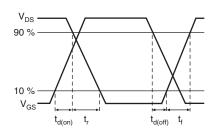


Fig. 13 - Switching Time Waveforms

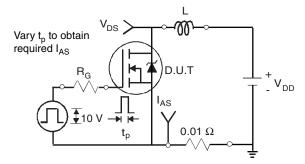


Fig. 14 - Unclamped Inductive Test Circuit

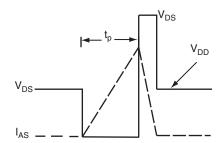


Fig. 15 - Unclamped Inductive Waveforms

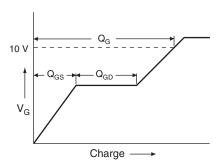


Fig. 16 - Basic Gate Charge Waveform

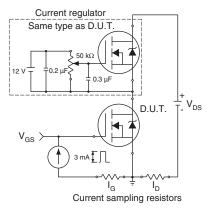
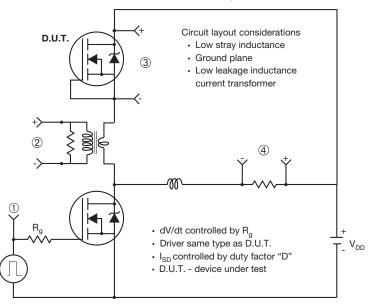


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



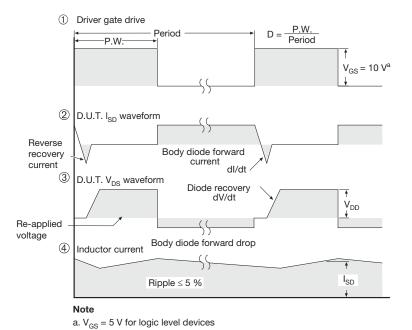
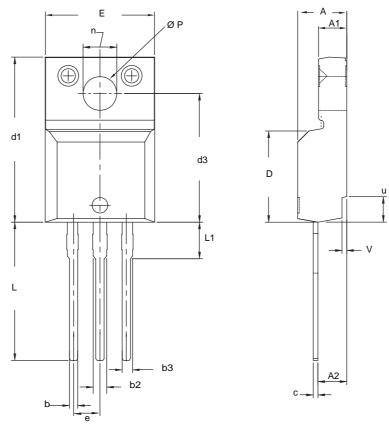


Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



	MILLIN	METERS	INCHE	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

DWG: 5972

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
 All dimensions include burrs and plating thickness.
 No chipping or package damage.



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